

**Search Notes**

Application/Control No.

10/632,011

Examiner

Hai C. Pham

Applicant(s)/Patent under  
Reexamination

SUBIRADA ET AL.

Art Unit

2861

**SEARCHED**

Class	Subclass	Date	Examiner
347	3, 5, 14- 16, 19, 32	2/18/2005	HP
399	49	2/18/2005	HP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST TEXT SEARCH	2/17/2005	HP
	2/18/2005	HP